Search Notes

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Application/Control No.	Applicant(s)/Patent under Reexamination NAKAMURA, MITSUAKI		
10/814,144			
Examiner	Art Unit		

Xavier Szewai Wong

2616

	SEARCHED		
Class	Subclass	Date	Examiner
370	512	8/4/2007	xsw
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INTERFERENCE SEARCHED			
Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST image and keyword search in USPAT, US-PGPUB, DERWENT, EPO, JPO, and IBM_TDB (please see search history)	8/4/2007	XSW
Inventor Name and Assignee search in PALM ExPO and EAST	8/4/2007	xsw
esp@cenet	8/4/2007	xsw
370/512,216-220.ccls.	8/5/2007	xsw
priorit\$3 and synchroni\$6	8/5/2007	xsw
(transmi\$6) same (multiply\$3 multiplication) same priority	8/5/2007	xsw